Customer No. 22,852 Attorney Docket No. 03180.0355

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re A	application of:)
Hiroshi MATSUSHITA et al.))) Crown Art Haite TDA
Application No.: Not Yet Assigned)) Group Art Unit: TBA) Examinar: Not yet assigned
Filed:	February 20, 2004) Examiner: Not yet assigned)
For:	FAILURE DETECTION SYSTEM, FAILURE DETECTION METHOD, AND COMPUTER PROGRAM PRODUCT	

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97(b)

Pursuant to 37 C.F.R. §§1.56 and 1.97(b), applicants bring to the Examiner's attention the documents listed on attached Form PTO-1449. Copies of the listed documents are attached. Applicants respectfully request that the Examiner consider the documents listed on attached Form PTO-1449 and indicate that they were considered by making an appropriate notation on this form.

This Information Disclosure Statement is being filed with the above-referenced application.

The following is listed on the accompanying PTO-1449 and is in a non-English language. An English-language abstract is enclosed.

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1. Japanese Patent Laid-Open (Kokai) No. 2002-359266 - The relevance of this document is discussed at page 3 of the present application.

This submission does not represent that a search has been made or that no better art exists and does not constitute an admission that each or all of the listed documents are material or constitute "prior art." If the Examiner applies any of the documents as prior art against any claim in the application and applicants determine that the cited documents do not constitute "prior art" under United States law, applicants reserve the right to present to the Office the relevant facts and law regarding the appropriate status of such documents. Applicants further reserve the right to take appropriate action to establish the patentability of the disclosed invention over the listed documents, should one or more of the documents be applied against the claims of the present application.

If there is any fee due in connection with the filing of this Statement, please charge the fee to our Deposit Account No. 06-0916.

Respectfully submitted,

FINNEGAN, HENDERSON, FARABOW, GARRETT & DUNNER, L.L.P.

Dated: February 24, 2004

Enclosures

RVB/FPD/cma

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INFORMATION DISCLOSURE CITATION

Atty. Docket No.	03180.0355	Application No.	ТВА
Applicants	Hiroshi MATSUSHITA et al.		
Filing Date	February 24, 2004	Group:	TBA .

	U.S. PATENT DOCUMENTS					
Examiner Initial*	Document Number	Issue Date	Name	Class	Sub Class	Filing Date If Appropriate
	2003-0011376	Jan. 16, 2003	Matsushita et al.	324	500	

FOREIGN PATENT DOCUMENTS						
	Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or No
	2002-359266	Dec. 13, 2002	Japan			Abstract
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		OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)			
		Mitsutake, K. et al., "New Method of Extraction of Systematic Failure Component", Proc. 10 th Int. Symp. Semiconductor Manufacturing, pp. 247-250, (2001)			
	Sugimoto, M. et al., "Characterization Algorithm of Failure Distribution for LSI Yield Improveme Proc. 10 th Int. Symp. Semiconductor Manufacturing, pp. 275-278, (2001)				
		Nakamae, K. et al., "Fail Pattern Classification and Analysis System of Memory Fail Bit Maps", Proc. 4 th Int. Conf. Modeling and Simulation of Microsystems, pp. 598-601, (2001)			
Examiner		Date Considered			
*Examiner:	thre	Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			
Form PTO 1449 Patent and		Patent and Trademark Office - U.S. Department of Commerce			